

# Schottky Barrier Diodes for General Purpose Applications

## Technical Data

**1N5711,  
JAN1N5711/TX/TXV  
1N5712,  
JAN1N5712/TX/TXV  
5082-2300 Series  
5082-2800 Series  
5082-2900 Series**

### Features

- **Low Turn-On Voltage**  
As Low as 0.34 V at 1 mA
- **Pico Second Switching Speed**
- **High Breakdown Voltage**  
Up to 70 V
- **Matched Characteristics Available**

### Description/ Applications

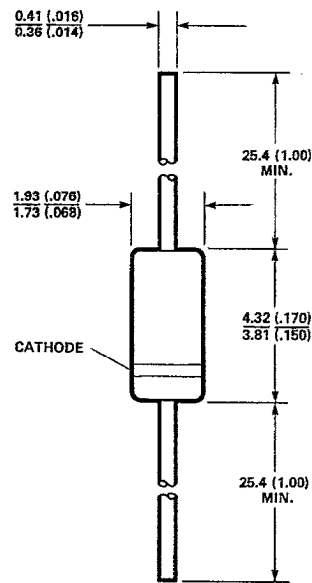
The 1N5711, 1N5712, 5082-2800/10/11 are passivated Schottky barrier diodes which use a patented "guard ring" design to achieve a high breakdown voltage. Packaged in a low cost glass package, they are well suited for high level detecting, mixing, switching, gating, log or A-D converting, video detecting, frequency discriminating, sampling, and wave shaping.

The 5082-2835 is a passivated Schottky diode in a low cost glass package. It is optimized for low turn-on voltage. The 5082-2835 is particularly well suited for the UHF mixing needs of the CATV marketplace.

The 5082-2300 and 2900 Series devices are unpassivated Schottky diodes in a glass

package. These diodes have extremely low  $1/f$  noise and are ideal for low noise mixing, and high sensitivity detecting. They are particularly well suited for use in Doppler or narrow band video receivers.

Note: The JAN Series 1N5711 and the JAN Series 1N5712 devices are well suited for applications that require the high reliability of a JAN/TX/TXV device. The TX and TXV devices have solder dipped leads. Both the JAN Series 1N5711 and 1N5712 undergo testing per MIL-STD-750. More information about these devices can be obtained through your local Hewlett-Packard field sales engineer.



DIMENSIONS IN MILLIMETERS AND (INCHES).

**Outline 15**

### Maximum Ratings

#### Junction Operating and Storage Temperature Range

5082-2301, -2302, -2303, -2900 .....	-60°C to +100°C
1N5711, 1N5712, 5082-2800/10/11 .....	-65°C to +200°C
5082-2835 .....	-60°C to +150°C

#### DC Power Dissipation

(Measured in an infinite heat sink at  $T_{CASE} = 25^{\circ}C$ )

Derate linearly to zero at maximum rated temperature

5082-2301, -2302, -2303, -2900 .....	100 mW
1N5711, 1N5712, 5082-2800/10/11 .....	250 mW
5082-2835 .....	150 mW

Peak Inverse Voltage.....  $V_{BR}$

**Package Characteristics**

**Outline 15**

Lead Material ..... Dumet  
 Lead Finish ..... 95-5% Tin-Lead  
 Max. Soldering Temperature ..... 260°C for 5 sec  
 Min. Lead Strength ..... 4 pounds pull  
 Typical Package Inductance  
   1N5711, 1N5712: ..... 2.0 nH  
   2800 Series: ..... 2.0 nH  
   2300, 2900 Series: ..... 3.0 nH  
 Typical Package Capacitance  
   1N5711, 1N5712: ..... 0.2 pF  
   2800 Series: ..... 0.2 pF  
   2300, 2900 Series: ..... 0.07 pF

The leads on the Outline 15 package should be restricted so that the bend starts at least 1/16 inch from the glass body.

Outline 15 diodes are available on tape and reel. The tape and reel specification is patterned after RS-296-D.

**Electrical Specifications at T<sub>A</sub> = 25°C**

**General Purpose Diodes**

Part Number	Package Outline	Min. Breakdown Voltage V <sub>BR</sub> (V)	Max. Forward Voltage V <sub>F</sub> (mV)	V <sub>F</sub> = 1 V Max. at Forward Current I <sub>F</sub> (mA)	Max. Reverse Leakage Current		Max. Capacitance C <sub>T</sub> (pF)
					I <sub>R</sub> (nA) at V <sub>R</sub> (V)		
5082-2800	15	70	410	15	200	50	2.0
1N5711	15	70	410	15	200	50	2.0
5082-2810	15	20	410	35	100	15	1.2
1N5712	15	20	550	35	150	16	1.2
5082-2811	15	15	410	20	100	8	1.2
5082-2835	15	8*	340	10**	100	1	1.0
Test Conditions		I <sub>R</sub> = 10 μA *I <sub>R</sub> = 100 μA	I <sub>F</sub> = 1 mA	*V <sub>F</sub> = 0.45 V			V <sub>R</sub> = 0 V f = 1.0 MHz

Note: Effective Carrier Lifetime (τ) for all these diodes is 100 ps maximum measured with Krakauer method at 5 mA except for 5082-2835 which is measured at 20 mA.

### Low 1/f (Flicker) Noise Diodes

Part Number 5082-	Package Outline	Min. Breakdown Voltage $V_{BR}$ (V)	Max. Forward Voltage $V_F$ (mV)	$V_F = 1$ V Max. at Forward Current $I_F$ (mA)	Max. Reverse Leakage Current $I_R$ (nA) at $V_R$ (V)	Max. Capacitance $C_T$ (pF)
2301	15	30	400	50	300 15	1.0
2302	15	30	400	35	300 15	1.0
2303	15	20	400	35	500 15	1.0
2900	15	10	400	20	100 5	1.2
Test Conditions		$I_R = 10 \mu A$	$I_F = 1$ mA			$V_R = 0$ V $f = 1.0$ MHz

Note: Effective Carrier Lifetime ( $\tau$ ) for all these diodes is 100 ps maximum measured with Krakauer method at 20 mA.

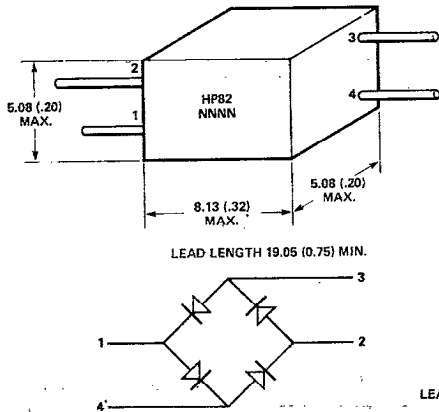
### Matched Pairs and Quads

Basic Part Number 5082-	Matched Pair Un-connected	Matched Quad Un-connected	Matched Ring Quad Encapsulated G-1 Outline	Matched Bridge Quad Encapsulated G-2 Outline	Batch Matched <sup>(1)</sup>	Test Conditions
2301	5082-2306 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF					$\Delta V_F$ at $I_F = 0.75, 20$ mA $\Delta C_O$ at $f = 1.0$ MHz
2303	5082-2308 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2370 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2396 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2356 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF		$\Delta V_F$ at $I_F = 0.75, 20$ mA $\Delta C_O$ at $f = 1.0$ MHz
2900	5082-2912 $\Delta V_F = 30$ mV	5082-2970 $\Delta V_F = 30$ mV		5082-2997 $\Delta V_F = 30$ mV		$\Delta V_F$ at $I_F = 1.0, 10$ mA
2800	5082-2804 $\Delta V_F = 20$ mV	5082-2805 $\Delta V_F = 20$ mV			5082-2836* $\Delta V_F = 20$ mV $\Delta C_O = 0.1$ pF	$\Delta V_F$ at $I_F = 0.5, 5$ mA * $I_F = 10$ mA $\Delta C_O$ at $f = 1.0$ MHz
2811		5082-2815 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2814 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2813 $\Delta V_F = 20$ mV $\Delta C_O = 0.2$ pF	5082-2826 $\Delta V_F = 10$ mV $\Delta C_O = 0.1$ pF	$\Delta V_F$ at $I_F = 10$ mA $\Delta C_O$ at $f = 1.0$ MHz
2835					5082-2080 $\Delta V_F = 10$ mV $\Delta C_O = 0.1$ pF	$\Delta V_F$ at $I_F = 10$ mA $\Delta C_O$ at $f = 1.0$ MHz

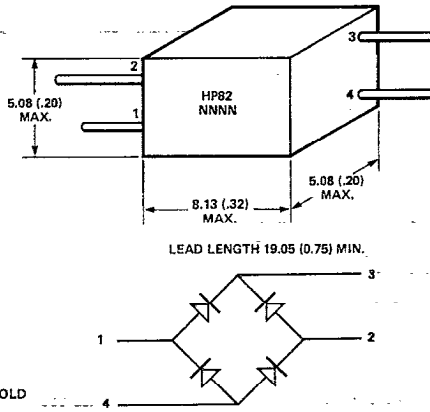
**Note:**

1. Batch matched devices have a minimum batch size of 50 devices.

**Outline G-1**

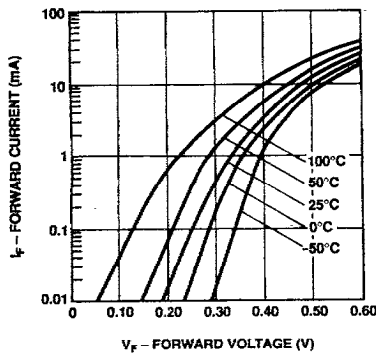


**Outline G-2**

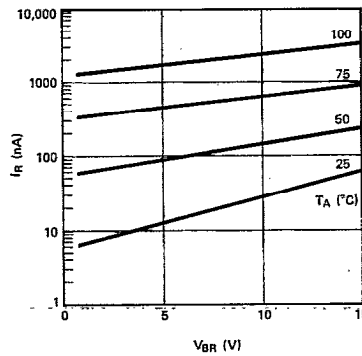


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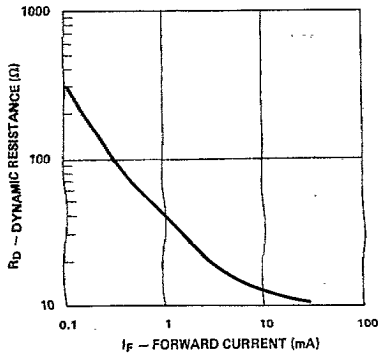
**Typical Parameters**



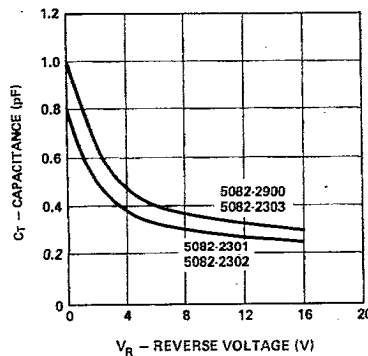
**Figure 1. I-V Curve Showing Typical Temperature Variation for 5082-2300 and 5082-2900 Series Schottky Diodes.**



**Figure 2. 5082-2300 Series Typical Reverse Current vs. Reverse Voltage at Various Temperatures.**

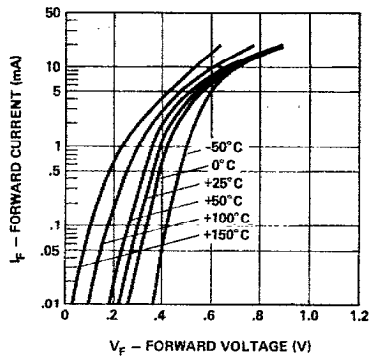


**Figure 3. 5082-2300 Series and 5082-2900 Series Typical Dynamic Resistance ( $R_D$ ) vs. Forward Current ( $I_F$ ).**

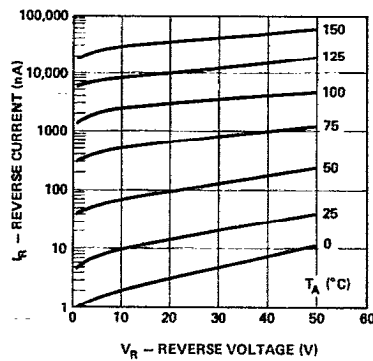


**Figure 4. 5082-2300 and 5082-2900 Series Typical Capacitance vs. Reverse Voltage.**

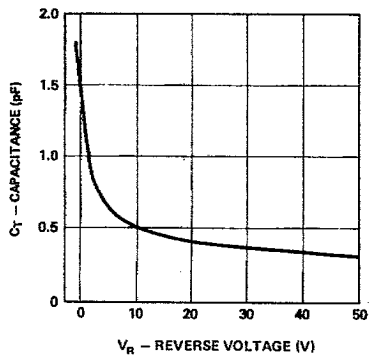
**Typical Parameters (continued)**



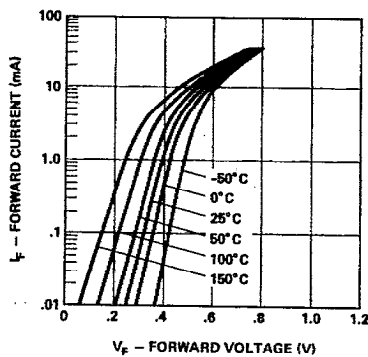
**Figure 5. I-V Curve Showing Typical Temperature Variation for 5082-2800 or 1N5711 Schottky Diodes.**



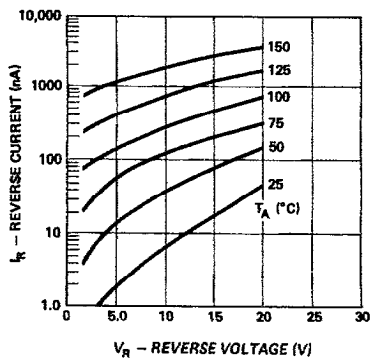
**Figure 6. (5082-2800 or 1N5711) Typical Variation of Reverse Current ( $I_R$ ) vs. Reverse Voltage ( $V_R$ ) at Various Temperatures.**



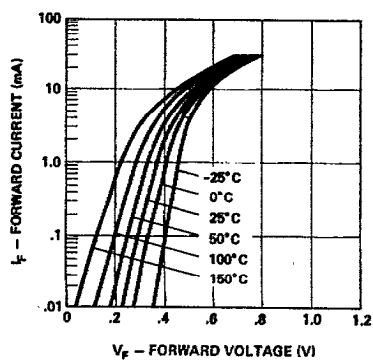
**Figure 7. (5082-2800 or 1N5711) Typical Capacitance ( $C_T$ ) vs. Reverse Voltage ( $V_R$ ).**



**Figure 8. I-V Curve Showing Typical Temperature Variation for the 5082-2810 or 1N5712 Schottky Diode.**



**Figure 9. (5082-2810 or 1N5712) Typical Variation of Reverse Current ( $I_R$ ) vs. Reverse Voltage ( $V_R$ ) at Various Temperatures.**



**Figure 10. I-V Curve Showing Typical Temperature Variation for the 5082-2811 Schottky Diode.**

### Typical Parameters (continued)

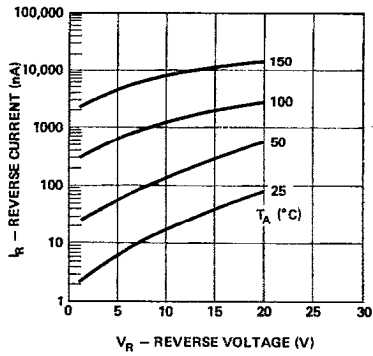


Figure 11. (5082-2811) Typical Variation of Reverse Current ( $I_R$ ) vs. Reverse Voltage ( $V_R$ ) at Various Temperatures.

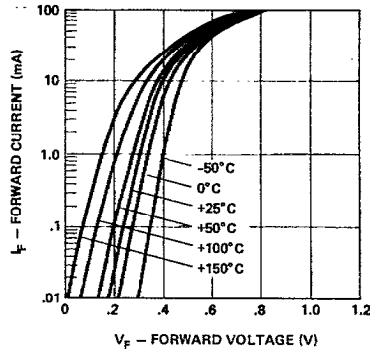


Figure 12. I-V Curve Showing Typical Temperature Variations for 5082-2835 Schottky Diode.

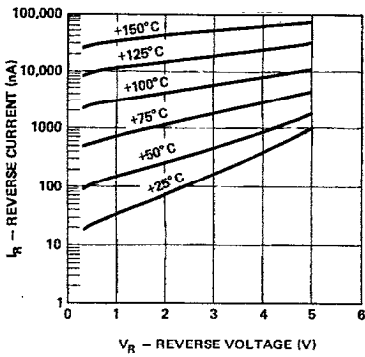


Figure 13. (5082-2835) Typical Variation of Reverse Current ( $I_R$ ) vs. Reverse Voltage ( $V_R$ ) at Various Temperatures.

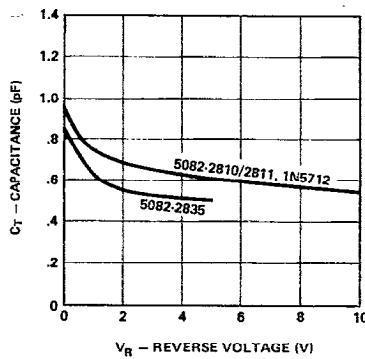


Figure 14. Typical Capacitance ( $C_T$ ) vs. Reverse Voltage ( $V_R$ ).

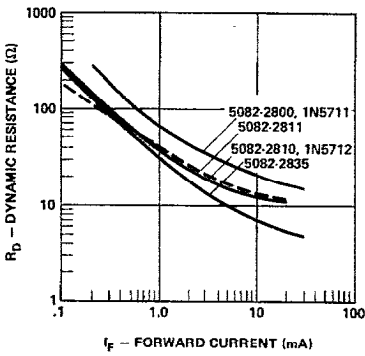


Figure 15. Typical Dynamic Resistance ( $R_D$ ) vs. Forward Current ( $I_F$ ).

# High Conductance Diodes

## Technical Data

**5082-1001**  
**5082-1002**  
**5082-1006**  
**(1N4456)**

### Features

- Fast Switching
- Low Capacitance
- High Current Capability

### Description/ Applications

The 5082-1000 series of diodes feature planar silicon epitaxial construction to provide high conductance, low capacitance, and nanosecond turn-on and turn-off. Turn-on time and voltage overshoot are minimized in these diodes of low conductivity modulation.

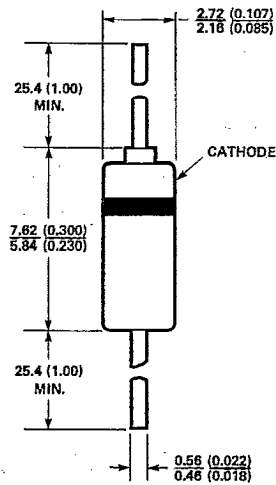
These diodes are ideally suited for applications such as core drivers, pulse generators, input gates, or wherever high conductance without loss of speed is required.

### Maximum Ratings

WIV – Working Inverse Voltage	
1001/1002 .....	30 V
1006 .....	40 V
I <sub>F</sub> (Surge) – Forward Current Surge,	
1.0 Sec. Duration .....	0.75 Amp
I <sub>F</sub> (Surge) – Forward Current Surge,	
1.0 Microsec. Duration .....	7.50 Amp
Power Dissipation <sup>(1)</sup> at T <sub>CASE</sub> = 25°C .....	500 mW
Junction Temperature Range .....	-65°C to +175°C
Storage Temperature Range .....	-65°C to +200°C

### Mechanical Specifications

The HP Outline 11 package has a glass hermetic seal with dumet leads. The package will meet MIL-STD-750, Method 2036, Conditions A (2 lbs. tension for 15 sec.), and E. The maximum soldering temperature is 230°C for 5 seconds. Outline 11 package capacitance and inductance are typically 0.15 pF and 4 nH respectively.



DIMENSIONS IN MILLIMETERS AND (INCHES)

**Outline 11B**